

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/689,814	HASSNER ET AL.	
Examiner	Art Unit	
R. Stephen Dildine	2133	

SEARCHED					
Class	Subclass	Date	Examiner		
714	766 & 770	5/15/2006	RSD		
714	804	5/16/2006	RSD		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	5/16/2006			
Google	5/16/2006	RSD		
IEEEXplore	5/16/2006	RSD		
Inventors' name search	5/15/2006	RSD		